



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 214438US0RD	SERIAL NO. 09/964,463	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Masaaki ONOMURA, et al.		
		FILING DATE September 28, 2001		GROUP 2811		
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
<i>GNM</i>	AA	5,732,098	03/24/98	K. NISITANI, et al.	372	45
<i>GNM</i>	AB	6,229,834	05/08/2001	K. NISITANI, et al.	372	45
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FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
<i>GNM</i>	AO	09-219556	08/19/97	JAPAN (with English Abstract)		X
<i>GNM</i>	AP	11-195840	07/21/99	JAPAN (with English Abstract)		X
<i>GNM</i>	AQ	11-238945	08/31/99	JAPAN (with English Abstract)		X
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)						
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Examiner <i>GNM</i>					Date Considered <i>10-03</i>	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						

SHEET 1 OF 2

Form PTO 1449 (Modified) LIST OF REFERENCES CITED BY APPLICANT		ATTY DOCKET NO. 214438US0RD		SERIAL NO. 09/964,463	
		APPLICANT Masaaki ONOMURA, et al.			
		FILING DATE 09/28/01		GROUP 2811	
		U.S. PATENT DOCUMENTS			
INER NL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
QML	AA 6,400,742	06/04/02	HATAKOSHI, et al.	372	46
QML	AB 6,252,894	06/26/01	SASANUMA, et al.	372	45
QML	AC 6,185,238	02/06/01	ONOMURA, et al.	372	44
QML	AD 6,121,634	09/19/00	SAITO, et al.	257	86
QML	AE 6,060,335	05/09/00	RENNIE, et al.	4372	45
QML	AF 6,005,263	12/21/99	SAITO, et al.	257	200
QML	AG 5,972,730	10/26/99	SAITO, et al.	438	39
QML	AH 6,031,858	02/29/00	HATAKOSHI, et al.	372	46
QML	AI 6,067,309	05/23/00	ONOMURA, et al.	372	46
QML	AJ 5,780,873	07/14/98	ITAYA, et al.	257	521
QML	AK 5,821,555	10/13/98	SAITO, et al.	257	13
QML	AL 5,696,389	12/09/97	ISHIKAWA, et al.	257	99
QML	AM 5,488,233	01/30/96	ISHIKAWA, et al.	257	94
QML	AN 5,347,526	09/13/94	SUZUKI, et al.	372	20
FOREIGN PATENT DOCUMENTS					
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
AO					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)					
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Examiner	<i>QML</i>			Date Considered	10-03
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		FILING DATE 09/28/01		GROUP 2811			
U.S. PATENT DOCUMENTS							
REF. L		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>SMC</i>	AA	5,253,264	10/12/93	SUZUKI, et al.	372	46	
<i>SMC</i>	AB	5,274,649	12/28/93	HIRAYAMA, et al.	372	20	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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Examiner <i>SMC</i>				Date Considered 10-03			
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